

MOSFET - N-Channel, QFET

800 V, 3.9 A, 3.6 Ω

FQB4N80

Description

This N-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. This device is suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 3.9 A, 800 V, $R_{DS(on)} = 3.6 \Omega$ (Max.) @ $V_{GS} = 10 \text{ V}$, $I_D = 1.95 \text{ A}$
- Low Gate Charge (Typ. 19 nC)
- Low C_{rss} (Typ. 8.6 pF)
- 100% Avalanche Tested
- This Device is Pb-Free and Halide Free

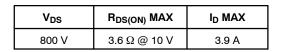
MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

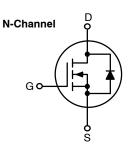
Symbol	R	Value	Unit	
V _{DSS}	Drain-Source Voltag	800	V	
I _D	Drain Current - C	3.9	Α	
	- C	2.47		
I _{DM}	Drain Current - P	15.6	Α	
V _{GSS}	Gate-Source Voltag	±30	V	
E _{AS}	Single Pulsed Avala	460	mJ	
I _{AR}	Avalanche Current	3.9	Α	
E _{AR}	Repetitive Avalanch	13	mJ	
dv/dt	Peak Diode Recove	4.0	V/ns	
P _D	Power Dissipation (T _A = 25°C)*		3.13	W
	Power Dissipation	(T _C = 25°C)	130	W
		- Derate above 25°C	1.04	W/°C
T _J , T _{STG}	Operating and Stora Range	–55 to +150	°C	
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

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- 1. Repetitive rating: pulse-width limited by maximum junction temperature.
- 2. L = 57 mH, I_{AS} = 3.9 A, V_{DD} = 50 V, R_{G} = 25 Ω , starting T_{J} = 25 $^{\circ}$ C.
- 3. $I_{SD} \le 3.9$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, starting $T_J = 25^{\circ}C$.

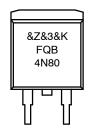






D²PAK-3 (TO-263, 3-LEAD) CASE 418AJ

MARKING DIAGRAMS



&Z = Assembly Plant Code
&3 = 3-Digit Date Code Format
&K = 2-Digits Lot Run Traceability Code

FQB4N80 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]		
FQB4N80TM	D ² PAK-3	800 / Tape & Reel		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	0.96	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (minimum pad of 2 oz copper), Max.	62.5	
	Thermal Resistance, Junction to Ambient (*1 in ² pad of 2 oz copper), Max.	40	

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit	
OFF CHAR	ACTERISTICS	•			•		
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	800	-	_	V	
ΔBV_{DSS}	Breakdown Voltage Temperature $I_D = 250 \mu A$, referenced to 2		-	0.95	-	V/°C	
ΔT_{J}	Coefficient						
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 800 V, V _{GS} = 0 V	_{iS} = 0 V – –		10	μΑ	
		V _{DS} = 640 V, T _C = 125°C	-	-	100	0	
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V	-	-	100	nA	
I _{GSSR}	Gate to Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V	-	-	-100	nA	
ON CHARA	ACTERISTICS	•					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	3.0	_	5.0	V	
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 1.95 A	-	2.8	3.6	Ω	
9 _{FS}	Forward Transconductance	V _{DS} = 50 V, I _D = 1.95 A	-	3.8	_	S	
DYNAMIC	CHARACTERISTICS						
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz	-	680	880	pF	
C _{oss}	Output Capacitance		-	75	100	pF	
C _{rss}	Reverse Transfer Capacitance		-	8.6	12	pF	
SWITCHIN	G CHARACTERISTICS						
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 400 \text{ V}, I_D = 3.9 \text{ A}, R_G = 25 \Omega$	-	16	40	ns	
t _r	Turn-On Rise Time	(Note 4)	-	45	100	ns	
t _{d(off)}	Turn-Off Delay Time		-	35	80	ns	
t _f	Turn-Off Fall Time		-	35	80	ns	
Qg	Total Gate Charge	$V_{DS} = 640 \text{ V}, I_D = 3.9 \text{ A}, V_{GS} = 10 \text{ V}$	-	19	25	nC	
Q_{gs}	Gate-Source Charge	(Note 4)	-	4.2	_	nC	
Q_{gd}	Gate-Drain Charge		i	9.1	_	nC	
DRAIN-SO	URCE DIODE CHARACTERISTICS AND M	IAXIMUM RATINGS					
I _S	Maximum Continuous Drain-Source Diode Forward Current		-	-	3.9	Α	
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	15.6	Α	
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 3.9 A	ì	_	1.4	V	
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 3.9 A,	ı	575	_	ns	
Q _{rr}	Reverse Recovery Charge	dI _F /dt = 100 A/μs	-	3.65	_	μC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature typical characteristics.

TYPICAL CHARACTERISTICS

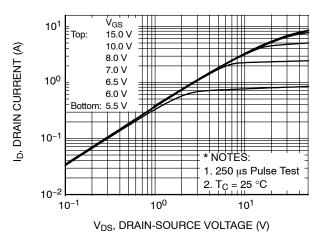


Figure 1. On-Region Characteristics

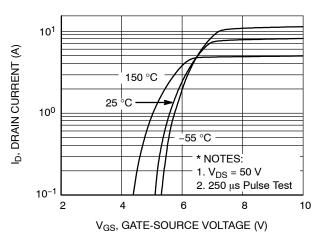


Figure 2. Transfer Characteristics

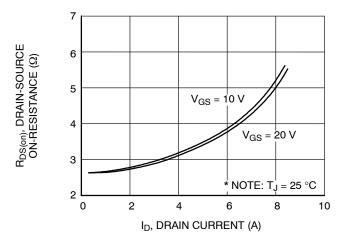


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

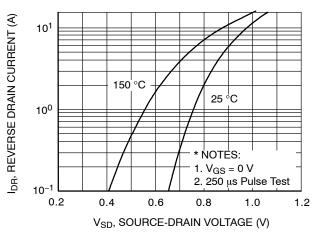


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

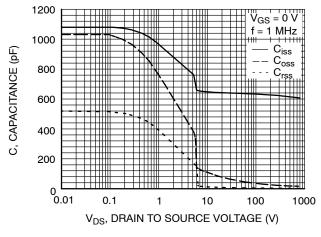


Figure 5. Capacitance Characteristics

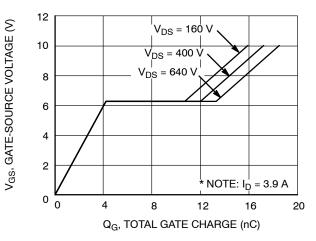
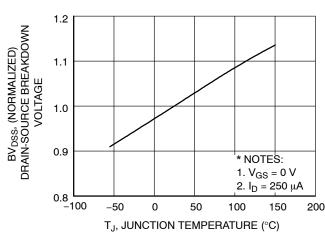


Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (continued)

3.0



NOTES:

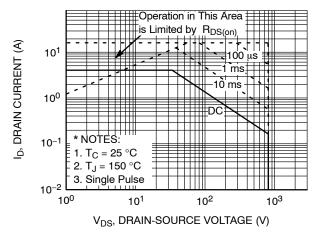
1.0

| CONT | CONT | CONT |

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Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



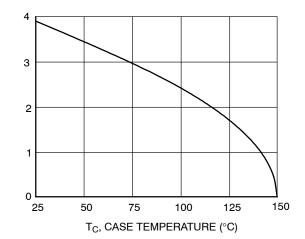
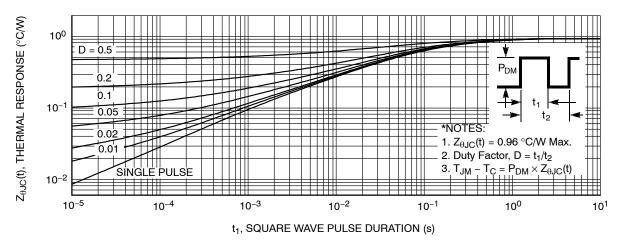


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature



ID, DRAIN CURRENT (A)

Figure 11. Transient Thermal Response Curve

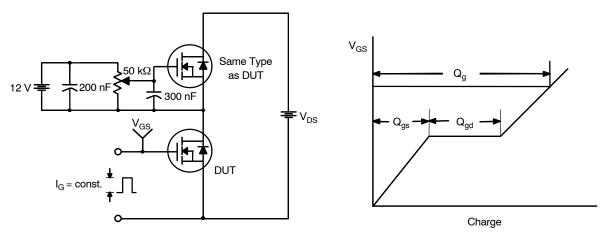


Figure 12. Gate Charge Test Circuit & Waveform

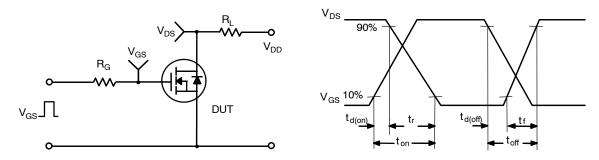


Figure 13. Resistive Switching Test Circuit & Waveforms

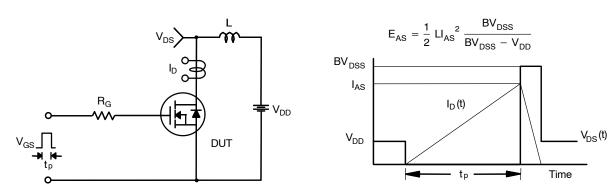


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

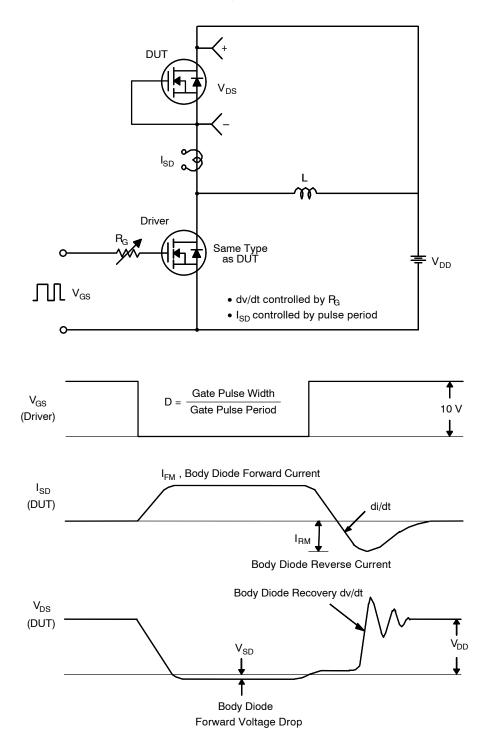


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





0.653

2x 0.063

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DATE 11 MAR 2021



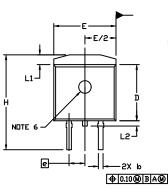
0.366

0.169

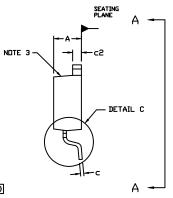
0.100 PITCH

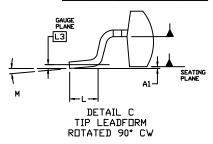
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- 3. CHAMFER OPTIONAL.
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE DUTERMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 5. THERMAL PAD CONTOUR IS OPTIONAL WITHIN DIMENSIONS E, L1, D1, AND E1.
- 6. OPTIONAL MOLD FEATURE.
- 7. ①,② ... OPTIONAL CONSTRUCTION FEATURE CALL DUTS.

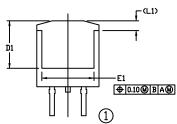
	INCHES		MILLIN	METERS
DIM	MIN.	MAX.	MIN.	MAX.
Α	0.160	0.190	4.06	4.83
A1	0.000	0.010	0.00	0.25
b	0.020	0.039	0.51	0.99
c	0.012	0.029	0.30	0.74
c2	0.045	0.065	1.14	1.65
D	0.330	0.380	8.38	9.65
D1	0.260		6.60	
E	0.380	0.420	9.65	10.67
E1	0.245		6.22	
e	0.100 BSC		2.54 BSC	
Ξ	0.575	0.625	14.60	15.88
L	0.070	0.110	1.78	2.79
L1		0.066		1.68
L2		0.070		1.78
L3	0.010 BSC		0.25 BSC	
М	0*	8*	0*	8•



RECOMMENDED MOUNTING FOOTPRINT



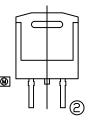




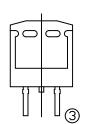
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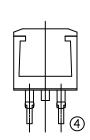
AWLYWWG

VIEW A-A



GENERIC MARKING DIAGRAMS*





VIEW A-A

OPTIONAL CONSTRUCTIONS

XXXXXX

XXYMW

SSG

AYWW

XXXXXXXXX

Rectifier

AKA

XXXXXX = Specific Device Code

A = Assembly Location

WL = Wafer Lot Y = Year

WW = Work Week

W = Week Code (SSG)

M = Month Code (SSG)

G = Pb-Free Package

AKA = Polarity Indicator

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " • ", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:

98AON56370E

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AYWW

Standard

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DESCRIPTION:

D²PAK-3 (TO-263, 3-LEAD)

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